Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/667,310	WAKAO ET AL.
Examiner	Art Unit
D	0405

SEARCHED					
Class	Subclass	Date	Examiner		
726	2	9/26/2007	ВТ		
726	4, 17, 27	9/26/2007	ВТ		
713	155, 161	9/26/2007	ВТ		
713	168-170	9/26/2007	ВТ		
713	176	9/26/2007	ВТ		
380	229, 232	9/26/2007	ВТ		
380	247	9/26/2007	ВТ		
382	100	9/26/2007	ВТ		
ALL	UPDATED	9/26/2007	ВТ		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
726	2, 4, 27	9/26/2007	ВТ	
713	176	9/26/2007	ВТ	
380	229, 232	9/26/2007	ВТ	
382/100		9/26/2007	ВТ	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST SEARCH (USPAT; USPGPUB; EPO; JPO; DERWENT; IBM_TDB)	9/26/2007	ВТ
INVENTORS SEARCH	9/26/2007	вт
GOOGLE SEARCH (NPL)	9/26/2007	вт
ACM SEARCH (NPL)	9/26/2007	BT
CONSULTED WITH PONNOREAY PICH (SEARCH MENTOR)	9/24/2007	вт
CONSUTED WITH THANHNGA TRUONG (PRIMARY EXAMINER)	9/25/2007	ВТ